

<b>Notice of References Cited</b>	Application/Control No. <b>09/524,755</b>		Applicant(s)/Patent Under Reexam <b>Peter Heinrich</b>	
	Examiner <b>Sheela Chawan</b>	Art Unit <b>2625</b>	Page 1 of 1	

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**NON-PATENT DOCUMENTS**

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